Application/Control No O9/834,501 Applicant(s)/Patent Under Reexamination SCHNEIDER ET AL. Examiner Luz L. Alejandro Applicant(s)/Patent Under Reexamination SCHNEIDER ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	К	US-			
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